FETKY™ Power MOSFET and Schottky Diode

-20 V, -3.3 A P-Channel with 20 V, 1.0 A Schottky Diode, Micro8™ Package

The FETKY product family incorporates low R_{DS(on)}, true logic level MOSFETs packaged with industry leading, low forward drop, low leakage Schottky Barrier Diodes to offer high efficiency components in a space saving configuration. Independent pinouts for TMOS and Schottky die allow the flexibility to use a single component for switching and rectification functions in a wide variety of applications.

Features

- Low V_F and Low Leakage Schottky Diode
- Lower Component Placement and Inventory Costs along with Board Space Savings
- Logic Level Gate Drive Can be Driven by Logic ICs
- Pb-Free Package is Available

Applications

- Buck Converter
- Synchronous Rectification
- Low Voltage Motor Control
- Load Management in Battery Packs, Chargers, Cell Phones, and other Portable Products

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

, , ,							
Rat	Symbol	Value	Unit				
Drain-to-Source Volta	age	ge V _{DS}		-20	V		
Gate-to-Source Volta	ge		V_{GS}	±10	V		
Continuous Drain		$T_A = 25^{\circ}C$	I _D	-3.3	Α		
Current (Note 1)		T _A = 100°C		-2.1			
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	1.42	W		
Continuous Drain		$T_A = 25^{\circ}C$	I_{D}	-2.4	Α		
Current (Note 2)		T _A = 100°C		-1.5			
Power Dissipation (Note 2)	Steady State	T _A = 25°C	P _D	0.78	W		
Pulsed Drain Current	t =	: 10 μs	I _{DM}	-10	Α		
Operating Junction and Storage Temperature		T_J, T_{STG}	–55 to 150	°C			
Single Pulse Drain–to–Source Avalanche Energy Starting T _A = 25°C (t ≤ 10 s)		EAS	150	mJ			
Lead Temperature for (1/8" from case for		Purposes	TL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- 2. Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.172 in sq).



ON Semiconductor®

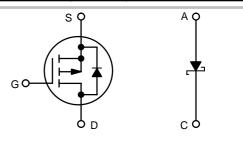
http://onsemi.com

MOSFET PRODUCT SUMMARY

V _{(BR)DSS}	R _{DS(on)} Typ	I _D Max
−20 V	70 mΩ @ –4.5 V	-3.3 A
20 V	100 mΩ @ –2.7 V	–2.7 A

SCHOTTKY DIODE SUMMARY

V _R Max	I _F Max	V _F Max
20 V	2.0 A	600 mV @ I _F = 2.0 A



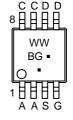
P-Channel MOSFET

Schottky Diode

MARKING DIAGRAM & PIN ASSIGNMENT



Micro8 **CASE 846A**



BG = Specific Device Code

WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTD4401FR2	Micro8	4000/Tape & Reel
NTTD4401FR2G	Micro8 (Pb-Free)	4000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

SCHOTTKY DIODE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	V	20	V
Average Forward Current (Rated V _R , T _A = 100°C)	I _O	1.0	Α
Peak Repetitive Forward Current (Note 3)	I _{FRM}	2.0	Α
Non-Repetitive Peak Surge Current (Note 4)	I _{FSM}	20	Α

THERMAL RESISTANCE RATINGS

		FET Schottky		
Rating	Symbol	Ma	ax	Unit
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	88	135	°C/W
Junction-to-Ambient - Steady State (Note 6)	$R_{\theta JA}$	160	250	°C/W

MOSFET ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

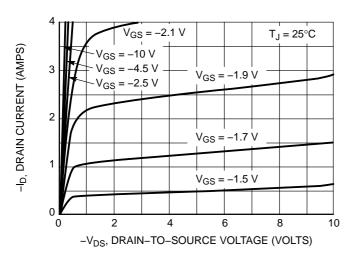
Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V	-20	_	-	V
Zero Gate Voltage Drain Current (Note 7)	I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = -16 \text{ V}$	_	-	-1.0	μΑ
		$V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C}, V_{DS} = -16 \text{ V}$	-	_	-25	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 10 \text{ V}$	_	_	±100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-0.5	_	-1.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	-	-	2.5	_	mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -3.3 \text{ A}$	_	70	90	mΩ
		$V_{GS} = -2.5 \text{ V}, I_D = -1.2 \text{ A}$	1	100	150	
Forward Transconductance	9FS	$V_{DS} = -10 \text{ V}, I_D = -2.7 \text{ A}$	-	4.2	-	S
CHARGES, CAPACITANCES AND GATE I	RESISTANCE					
Input Capacitance	C _{ISS}		-	550	750	pF
Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -16 \text{ V}$	_	200	300	1
Reverse Transfer Capacitance	C _{RSS}	DS = 19 V		50	175	1
Total Gate Charge	Q _{G(TOT)}		1	10	18	nC
Gate-to-Source Gate Charge	Q_{GS}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -16 \text{ V},$ $I_{D} = -3.3 \text{ A}$	1	1.5	3.0	
Gate-to-Drain "Miller" Charge	Q_{GD}	.,,	1	5.0	10	
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(ON)}		-	11	20	ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$	_	35	65	
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_{D} = -3.3 \text{ A}, R_{G} = 6.0 \Omega$	1	33	60	
Fall Time	t _f		_	29	55	
DRAIN-SOURCE DIODE CHARACTERIST	rics					
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = -2.0 \text{ A}$	_	-0.88	-1.0	V
Reverse Recovery Time	t _{RR}		_	37	50	ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, } d_{IS}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -3.3 \text{ A}$	_	16	-	
Discharge Time	t _b]	-	21	-	
Reverse Recovery Charge	Q _{RR}	-	-	0.025	0.05	nC

- Rated V_R, square wave, 20 kHz, T_A = 105°C.
 Surge applied at rated load conditions, half–wave, single phase, 60 Hz.
 Surface–mounted on FR4 board using 1 inch sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
 Surface–mounted on FR4 board using the minimum recommended pad size (Cu area = 0.172 in sq).
 Body diode leakage current.

SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS (T $_J$ = 25 $^{\circ}$ C unless otherwise noted)

Characteristic	Symbol	Test Condition I _R = 1.0 mA		Min	Тур	Max	Unit
Reverse Breakdown Voltage	B _V			20	-	-	V
Reverse Leakage Current	I _R	V 20.V	T _A = 25°C	-	-	0.05	mA
		$V_R = 20 \text{ V}$	T _A = 125°C	-	_	10	
Forward Voltage	V _F		T _A = 25°C	-	-	0.5	V
		I _F = 1.0 A	T _A = 125°C	-	_	0.39	
			T _A = 25°C	_	-	0.6	
		I _F = 2.0 A	T _A = 125°C	-	_	0.53	
Voltage Rate of Change	dV/dt	V _R = 20 V		-	10,000	-	V/μs

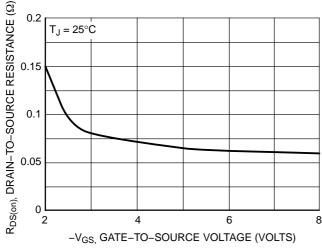
TYPICAL ELECTRICAL CHARACTERISTICS



S VDS > = -10 V VDS > = -10 V

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



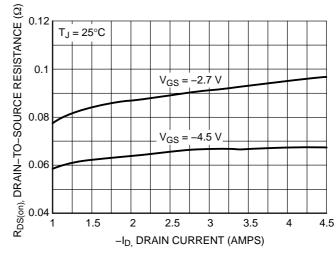
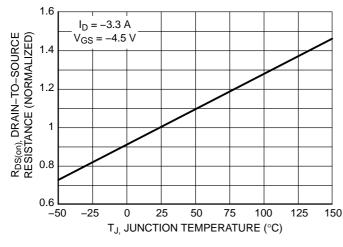


Figure 3. On–Resistance vs. Gate–to–Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



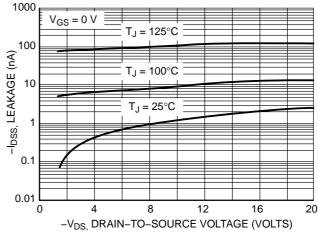
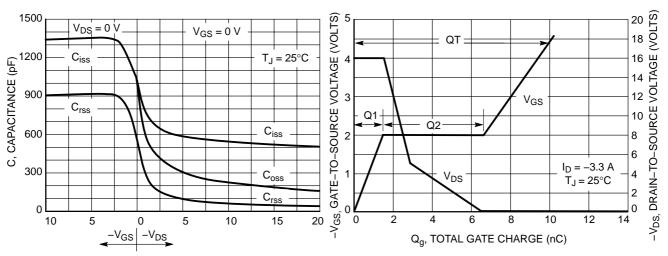


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

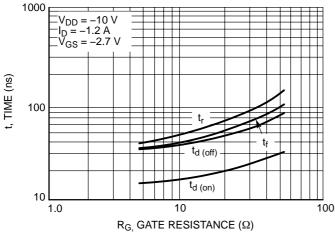


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

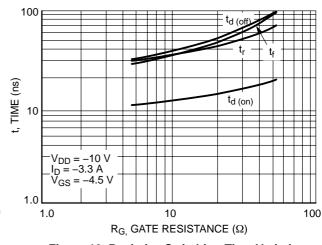


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

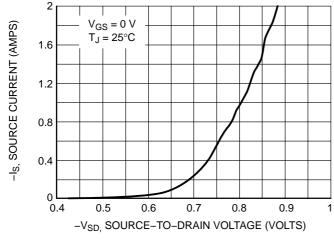


Figure 11. Diode Forward Voltage vs. Current

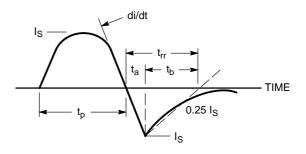


Figure 12. Diode Reverse Recovery Waveform

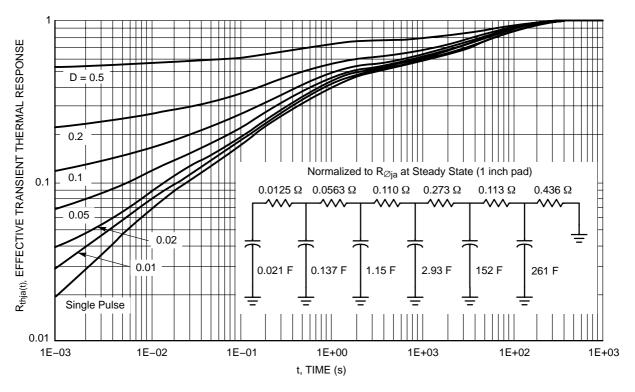


Figure 13. FET Thermal Response

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

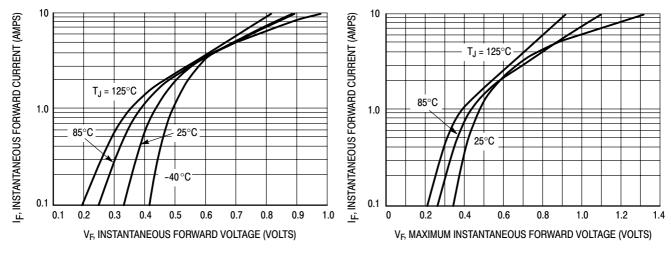


Figure 14. Typical Forward Voltage

Figure 15. Maximum Forward Voltage

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

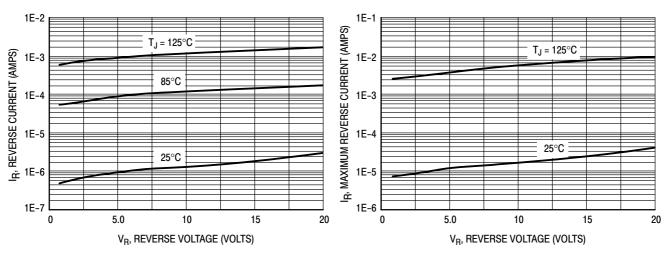


Figure 16. Typical Reverse Current

Figure 17. Maximum Reverse Current

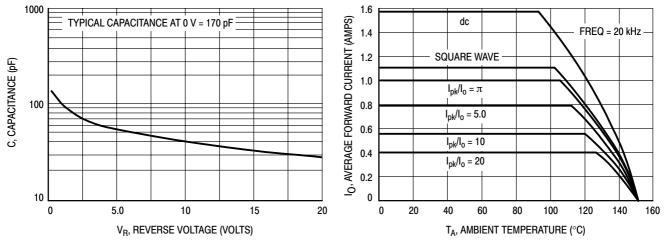


Figure 18. Typical Capacitance

Figure 19. Current Derating

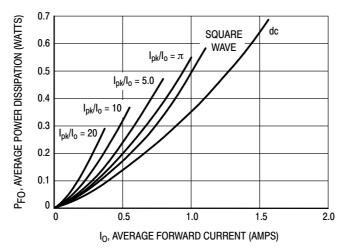
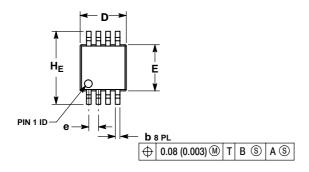
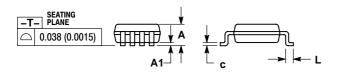


Figure 20. Forward Power Dissipation

PACKAGE DIMENSIONS

Micro8™ CASE 846A-02 ISSUE G

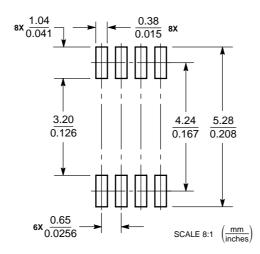




- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
 DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION.
- INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE. 846A-01 OBSOLETE, NEW STANDARD 846A-02.

	М	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	MOM	MAX	
Α			1.10			0.043	
A1	0.05	0.08	0.15	0.002	0.003	0.006	
b	0.25	0.33	0.40	0.010	0.013	0.016	
С	0.13	0.18	0.23	0.005	0.007	0.009	
D	2.90	3.00	3.10	0.114	0.118	0.122	
E	2.90	3.00	3.10	0.114	0.118	0.122	
е		0.65 BSC		0.026 BSC			
L	0.40	0.55	0.70	0.016	0.021	0.028	
HE	4.75	4.90	5.05	0.187	0.193	0.199	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

FETKY and Micro8 are registered trademarks of International Rectifier Corporation.

ON Semiconductor and un are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice on semiconductor and are registered traderlanks of semiconductor Components industries, ICC (SCILLC) services the right to make so controlled the register of the application or use of any product services any lability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA **Phone**: 303–675–2175 or 800–344–3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5773-3850

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative